


<b>Search Notes</b>  	<b>Application/Control No.</b>  10594279	<b>Applicant(s)/Patent Under Reexamination</b>  ISHIBASHI ET AL.
	<b>Examiner</b>  Dalena Tran	<b>Art Unit</b>  3664

SEARCHED			
Class	Subclass	Date	Examiner
701	50-55, 61, 62, 64		
477	34, 36, 20		
192	20, 147	2/1/10	DT

SEARCH NOTES			
Search Notes		Date	Examiner
EAST		2/1/10	DT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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